Docket No.

246496US2S

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Keiichi KUSHIDA

SERIAL NO: New Application

GAU:

FILED:

Herewith

EXAMINER:

FOR:

SEMICONDUCTOR MEMORY INCLUDING ERROR CORRECTION FUNCTION

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☐ Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Marvin J. Spivak

Registration No. 24,913

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STATEMENT OF RELEVANCY

Reference AO (2000-242515) of Form PTO-1449:

This publication is referred to in the specification. See page 6, line 12.

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO.				
			246496US2S	New Application					
				APPLICANT					
LIST OF	REFE	RENCES CITED BY AF	PPLICANT	Keiichi KUSHIDA					
				FILING DATE		GROUP			
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				U.S. PATENT DOCUMENTS					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
	AW	Kiyohiro FURUTANI, et al., "A BUILT-IN HAMMING CODE ECC CIRCUIT FOR DRAM'S", IEEE Journal of Solid-State Circuits, Vol. 24, No. 1, February 1989, pgs. 50 - 56.							
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	AZ				Additional References sheet(s) attached				
Examiner					Date Co	Date Considered			
*Examiner: Ir	nitial if r	eference is considered	, whether or no	t citation is in conformance with MPEP 6	09; Draw li	ne through	citation	if not in	
				n with next communication to applicant.					